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Applicant: BERTENSHAW ET ALFiling Date: 13 APR 1995

Group Art Unit: _____

LIST OF DOCUMENTS CITED BY APPLICANT

U.S. PATENT DOCUMENTS:

<u>*Exmr In.</u>	<u>Document#</u>	<u>Issue Date</u>	<u>Name</u>	<u>Class</u>	<u>Subclass</u> <u>Filing Date</u>
BD ↓	AA 4,240,820	23 Dec 80	Dickore et al	549	68
	AB 5,196,532	23 Mar 93	Wuest et al	544	114
	AC 4,990,647	5 Feb 91	Himmler et al	558	414
	AD 3,743,656	3 Jul 73	Brown et al	549	66

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BD ↓	AH 317,845	Nov. 1988	EPO		
	AI 4,279,672	Oct. 1992	JAPAN (english translation)		
	AJ 5,012,261	Sept. 1975	JAPAN (Derwent Abstract)		
	AK 48,091,061	Nov. 1973	JAPAN (Derwent Abstract)		
	AL 48,091,058	Nov. 1973	JAPAN (Derwent Abstract)		

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<u>*Exmr In.</u>	<u>Author</u>	<u>Publc. Title</u>	<u>Vol#</u>	<u>Page#</u>	<u>Publc. Date</u>
BD ↓	AP	Yang et al, <u>J. Chem. Soc.</u> , 656, (1992)			
	AQ	Kuo et al, <u>Chem. Pharm. Bull.</u> , 29, 635-45 (1981)			
	AR	Lai et al, <u>Tet. Lett.</u> , 29, 3483-86 (1988)			

Examiner: B. DentyDate Considered: 10-27-1995

#Examiner - Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.